


<b>Search Notes</b>  	<b>Application/Control No.</b>  10598010	<b>Applicant(s)/Patent Under Reexamination</b>  IKEUCHI ET AL.
	<b>Examiner</b>  SHEELA C CHAWAN	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	154, 190, 170, 218	7/30/10	SCC
345	419, 424	"	"
600	493, 554, 595, 300,	"	"
374	E1.005, E1.002,	"	"
324	76.11, 76.19	"	"

SEARCH NOTES			
Search Notes		Date	Examiner
SEARCH EAST AND OTHER DATA BASE, SEE THE SEARCH HISTORY.		7/30/10	SCC
INVENTOR NAME SEARCH.		"	"

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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